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# P-Channel 150 V (D-S) MOSFET

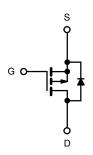
PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)	
- 150	0.065 at V <sub>GS</sub> = - 10 V	- 40	75 nC	
- 150	0.070 at V <sub>GS</sub> = - 4.5 V	- 38	75110	

#### **FEATURES**

- Maximum 175 °C junction temperature
- 100 % R<sub>g</sub> and UIS tested
- DT-TrenchPower MOSFET







P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $(T_A = 2)$	25 °C, unless othe	rwise noted)			
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	- 150	V		
Gate-Source Voltage		V <sub>GS</sub>	± 20	V	
	T <sub>C</sub> = 25 °C		- 40	A	
Ocationary Busin Company (T., 450,00)b	T <sub>C</sub> = 70 °C	l <sub>D</sub>	- 33		
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>b</sup>	T <sub>A</sub> = 25 °C		- 12 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C	1 [	- 8.5 <sup>b, c</sup>		
Pulsed Drain Current		I <sub>DM</sub>	I <sub>DM</sub> - 155		
Continuous Course Current (Diada Conduction)	T <sub>C</sub> = 25 °C	1.	- 40 <sup>a</sup>		
Continuous Source Current (Diode Conduction)	T <sub>A</sub> = 25 °C	- I <sub>S</sub>	- 5.25 <sup>b, c</sup>		
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	- 38		
Single Pulse Avalanche Energy		E <sub>AS</sub>	425	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	P <sub>D</sub>	285	W	
Maximum Fower Dissipation	T <sub>C</sub> = 70 °C	] 'D [	199		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
horation to Ambienta	t ≤ 10 s	$R_{thJA}$	15	18	°C/W
Junction-to-Ambient <sup>a</sup>	Steady State		40	50	
Junction-to-Case (Drain)		R <sub>thJC</sub>	0.55	1.2	

#### Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. Maximum under steady state conditions is 50  $^{\circ}\text{C/W}$ .

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, I}_{D} = -250 \mu\text{A}$	- 150			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = - 250 μA		- 109		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	η = - 250 μΑ		5.9			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1.5		- 3.5	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 120 V, V <sub>GS</sub> = 0 V			- 1	4	
		V <sub>DS</sub> = - 120 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = -10 \text{ V}$	- 40			Α	
Drain-Source On-State Resistance <sup>a</sup>	Б	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 10 A		0.065	0.078		
	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 8 A		0.070	0.085	Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 10 A		18		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			6100		pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 50 V, V <sub>GS</sub> = 0 V, f = 1 MHz		730			
Reverse Transfer Capacitance	C <sub>rss</sub>			85			
Tatal Cata Chausa	Qg	$V_{DS} = -50 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -10 \text{ A}$	75 110		110		
Total Gate Charge				34	50	nC	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = -50 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -8 \text{ A}$		14			
Gate-Drain Charge	$Q_{gd}$			26			
Gate Resistance	$R_g$	f = 1 MHz		5		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			25			
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 50 V, $R_L$ = 6.5 $\Omega$		70		ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong -10 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		43			
Fall Time	t <sub>f</sub>			40			
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 40	^	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 155	_ A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 7.7 A		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			60	90	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	 		150	225	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = -7.7 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		46			
Reverse Recovery Rise Time	t <sub>b</sub>	7		14		ns	

#### Notes:

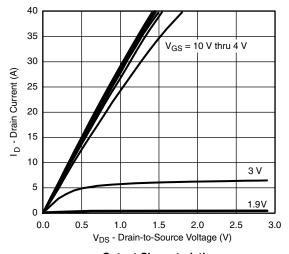
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

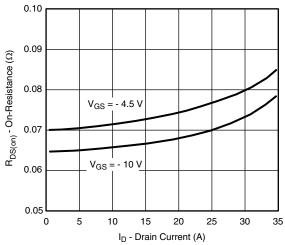
b. Guaranteed by design, not subject to production testing.



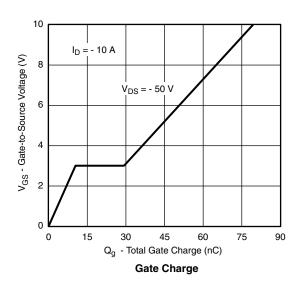
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

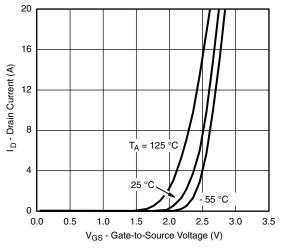


## **Output Characteristics**

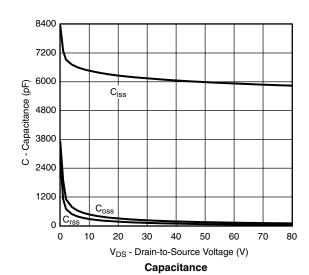


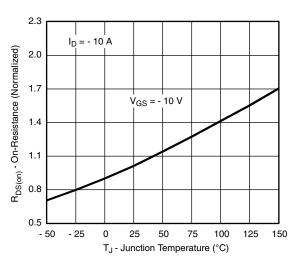
On-Resistance vs. Drain Current and Gate Voltage





**Transfer Characteristics** 

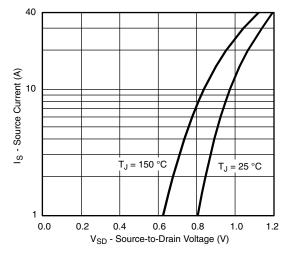




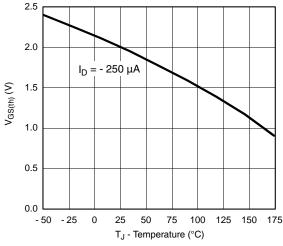
On-Resistance vs. Junction Temperature



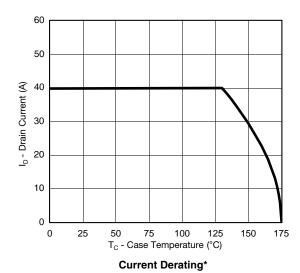
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

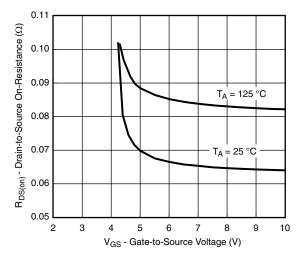


#### Source-Drain Diode Forward Voltage

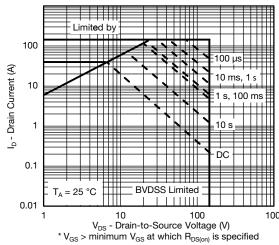


**Threshold Voltage** 

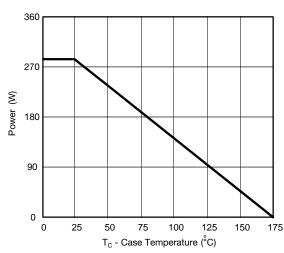




On-Resistance vs. Gate-to-Source Voltage



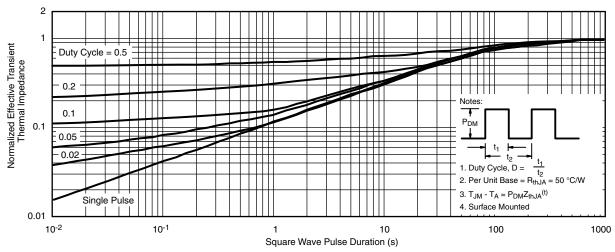
Safe Operating Area, Junction-to-Ambient



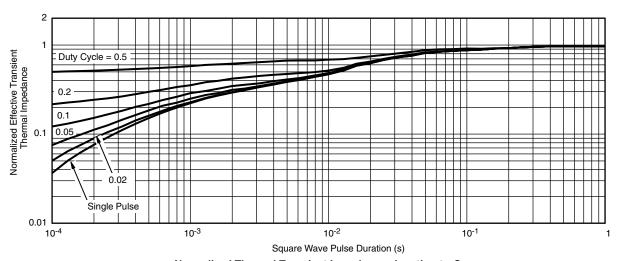
Single Pulse Power, Junction-to-Ambient



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case





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